CSD18510KTT 40V N 沟道 NexFET™ 功率 MOSFET

1 特性

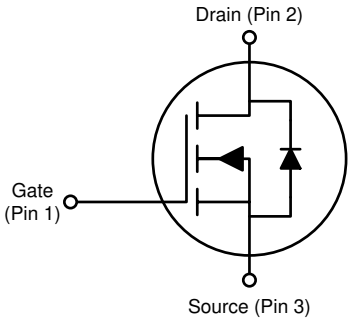
- 超低 Q_g 和 Q_{gd}
- 低热阻
- 雪崩级
- 无铅端子镀层
- 符合 RoHS
- 无卤素
- D^2PAK 塑料封装

2 应用

- 次级侧同步整流器
- 电机控制

3 说明

这款 40V、1.4mΩ、D^2PAK (TO-263) NexFET™ 功率 MOSFET 旨在用于更大限度地降低功率转换应用中的损耗。



产品概要

T_A = 25°C		典型值		单位
V_{DS}	漏源电压	40		V
Q_g	栅极电荷总量 (10V)	119		nC
Q_{gd}	栅极电荷（栅极到漏极）	21		nC
$R_{DS(on)}$	漏源导通电阻	V_{GS} = 4.5V	2.0	mΩ
		V_{GS} = 10V	1.4	
$V_{GS(th)}$	阈值电压	1.7		V

器件信息 (1)

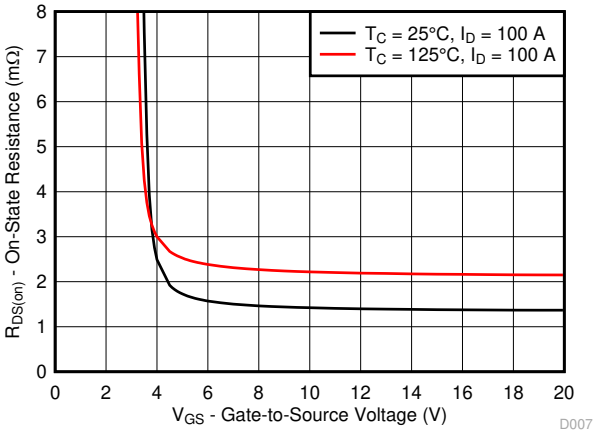
器件	数量	介质	封装	运输
CSD18510KTT	500	13 英寸卷带	D^2PAK 塑料封装	卷带包装
CSD18510KTTT	50			

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。

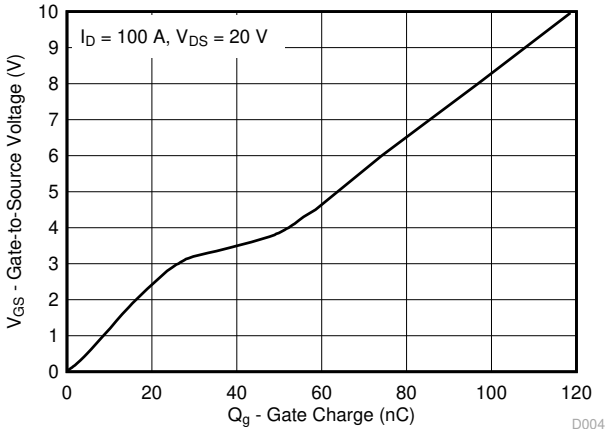
绝对最大额定值

T_A = 25°C		值	单位
V_{DS}	漏源电压	40	V
V_{GS}	栅源电压	±20	V
I_D	持续漏极电流（受封装限制）	200	A
	持续漏极电流（受器件限制），T_C = 25°C 时测得	274	
	持续漏极电流（受器件限制），T_C = 100°C 时测得	193	
I_{DM}	脉冲漏极电流(1)	400	A
P_D	功率耗散	250	W
T_J、T_{stg}	工作结温，贮存温度	-55 至 175	°C
E_{AS}	雪崩能量，单脉冲 I_D = 81A，L = 0.1mH，R_G = 25Ω	328	mJ

(1) 最大 $R_{\theta JC}$ = 0.6°C/W，脉冲持续时间 ≤ 100μs，占空比 ≤ 1%。



$R_{DS(on)}$ 与 V_{GS} 之间的关系



栅极电荷

Table of Contents

4 Specifications

4.1 Electrical Characteristics

T_A = 25°C (unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC CHARACTERISTICS						
BV_{DSS}	Drain-to-source voltage	V_{GS} = 0V, I_D = 250 μA	40			V
I_{DSS}	Drain-to-source leakage current	V_{GS} = 0V, V_{DS} = 32V			1	μA
I_{GSS}	Gate-to-source leakage current	V_{DS} = 0V, V_{GS} = 20V			100	nA
$V_{GS(th)}$	Gate-to-source threshold voltage	V_{DS} = V_{GS}, I_D = 250 μA	1.4	1.7	2.3	V
$R_{DS(on)}$	Drain-to-source on resistance	V_{GS} = 4.5V, I_D = 100A		2.0	2.6	mΩ
		V_{GS} = 10V, I_D = 100A		1.4	1.7	
g_{fs}	Transconductance	V_{DS} = 4V, I_D = 100A		330		S
DYNAMIC CHARACTERISTICS						
C_{iss}	Input capacitance	V_{GS} = 0V, V_{DS} = 20V, f = 1MHz		8770	11400	pF
C_{oss}	Output capacitance			832	1080	pF
C_{rss}	Reverse transfer capacitance			424	551	pF
R_G	Series gate resistance			0.9	1.8	Ω
Q_g	Gate charge total (4.5V)	V_{DS} = 20V, I_D = 100A		58	75	nC
Q_g	Gate charge total (10V)			118	153	nC
Q_{gd}	Gate charge gate-to-drain			21		nC
Q_{gs}	Gate charge gate-to-source			28		nC
$Q_{g(th)}$	Gate charge at V_{th}			15		nC
Q_{oss}	Output charge	V_{DS} = 20V, V_{GS} = 0V		35		nC
$t_{d(on)}$	Turnon delay time	V_{DS} = 20V, V_{GS} = 10V, I_{DS} = 100A, R_G = 0Ω		10		ns
t_r	Rise time			8		ns
$t_{d(off)}$	Turnoff delay time			29		ns
t_f	Fall time			8		ns
DIODE CHARACTERISTICS						
V_{SD}	Diode forward voltage	I_{SD} = 100A, V_{GS} = 0V		0.85	1.0	V
Q_{rr}	Reverse recovery charge	V_{DS}= 20V, I_F = 100A, di/dt = 300A/μs		70		nC
t_{rr}	Reverse recovery time			41		ns

4.2 Thermal Information

T_A = 25°C (unless otherwise stated)

THERMAL METRIC		MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-case thermal resistance			0.6	°C/W
$R_{\theta JA}$	Junction-to-ambient thermal resistance			62	°C/W

4.3 Typical MOSFET Characteristics

T_A =25°C (unless otherwise stated)

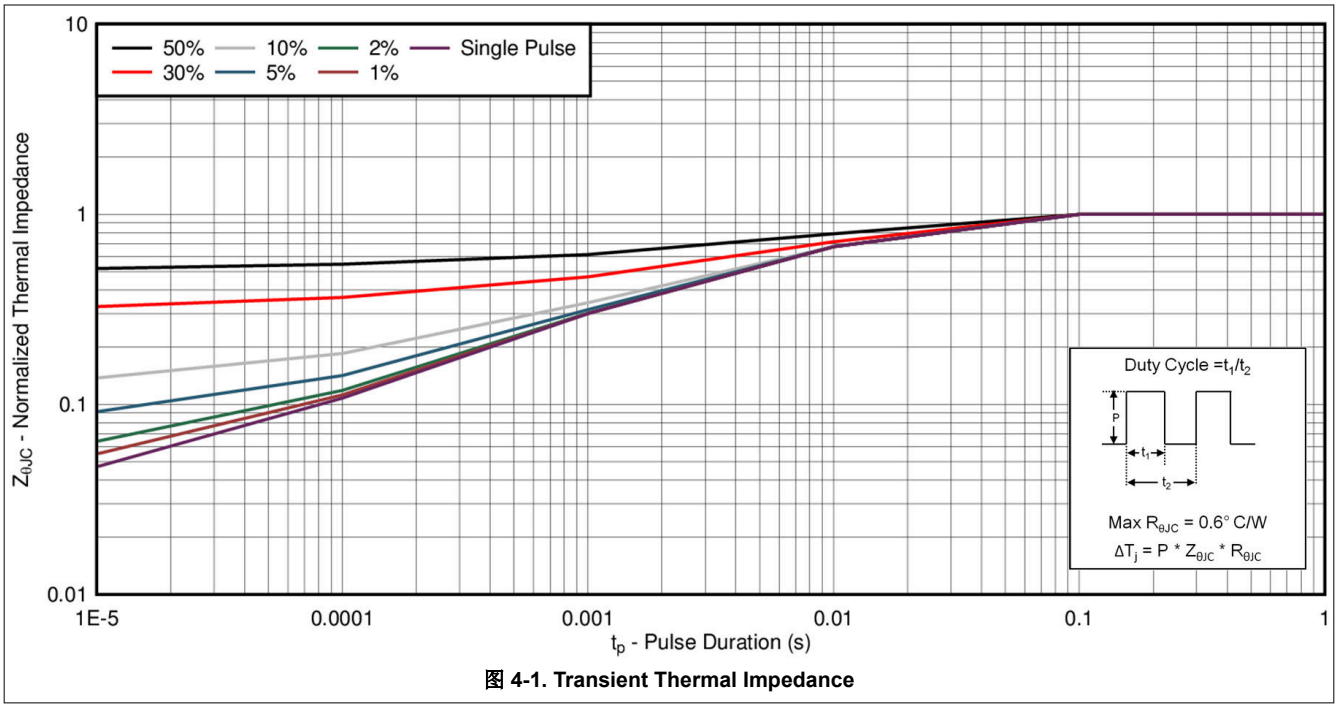


图 4-1. Transient Thermal Impedance

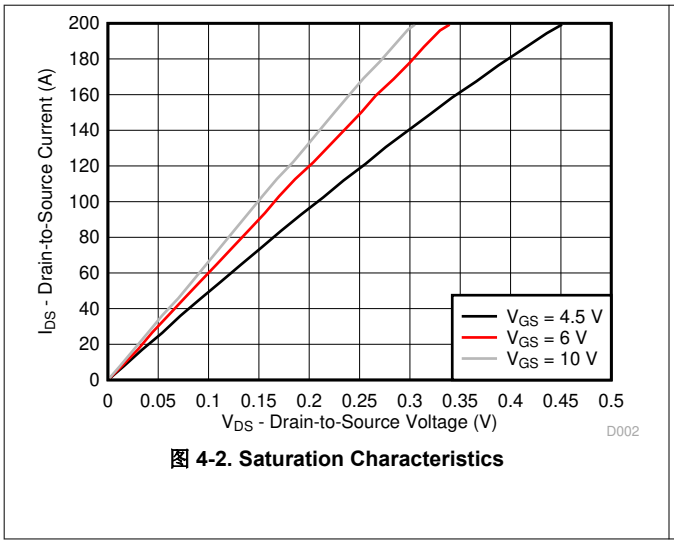
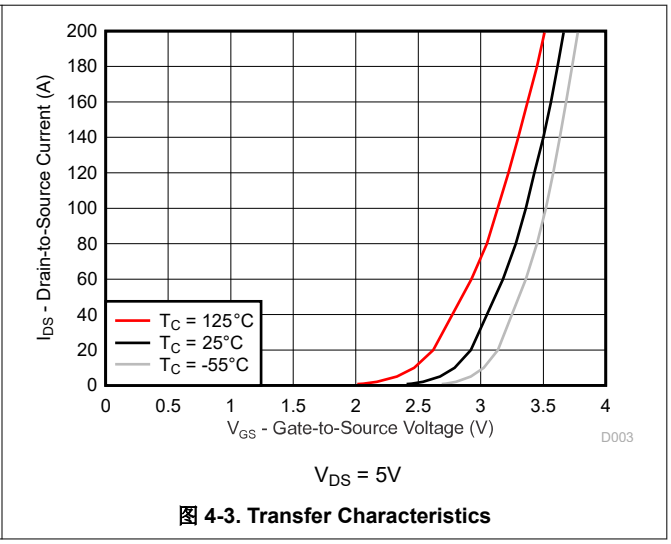


图 4-2. Saturation Characteristics

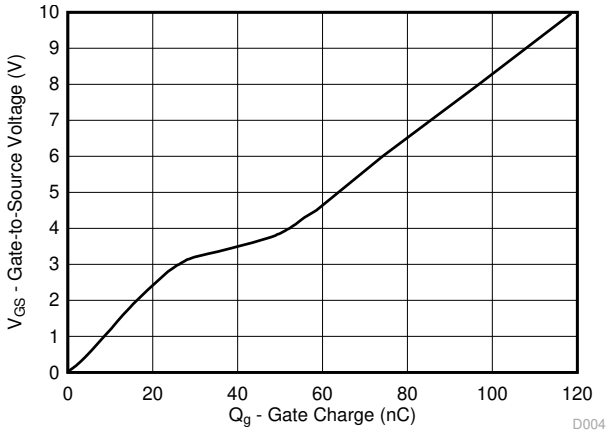


V_{DS} = 5V

图 4-3. Transfer Characteristics

4.3 Typical MOSFET Characteristics (continued)

T_A =25°C (unless otherwise stated)



V_{DS} = 20V I_D = 100A

图 4-4. Gate Charge

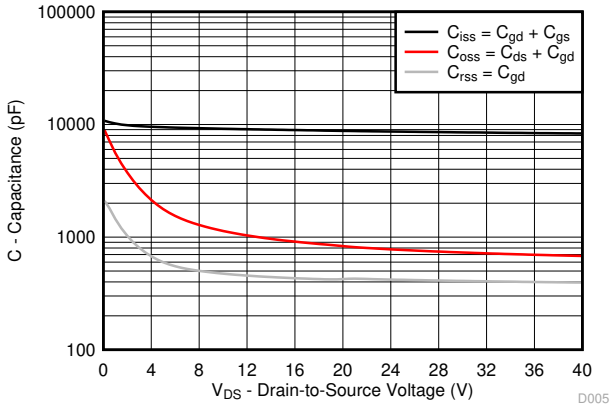
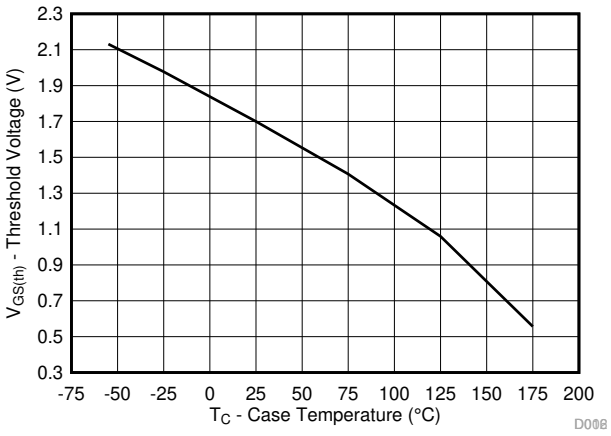


图 4-5. Capacitance



I_D = 250µA

图 4-6. Threshold Voltage vs Temperature

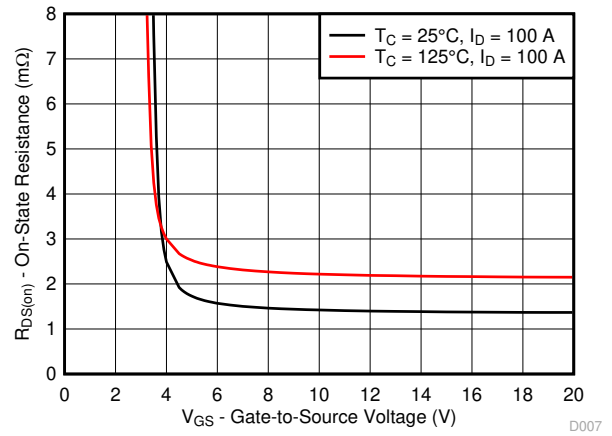
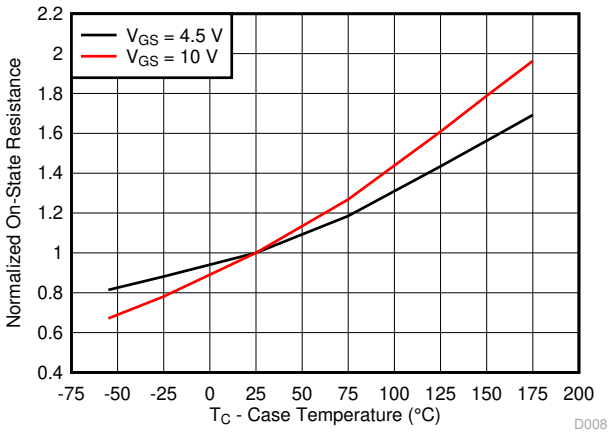


图 4-7. On-State Resistance vs Gate-to-Source Voltage



I_D = 100A

图 4-8. Normalized On-State Resistance vs Temperature

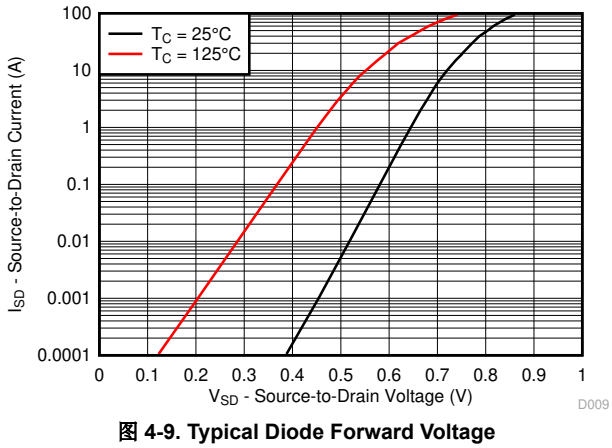
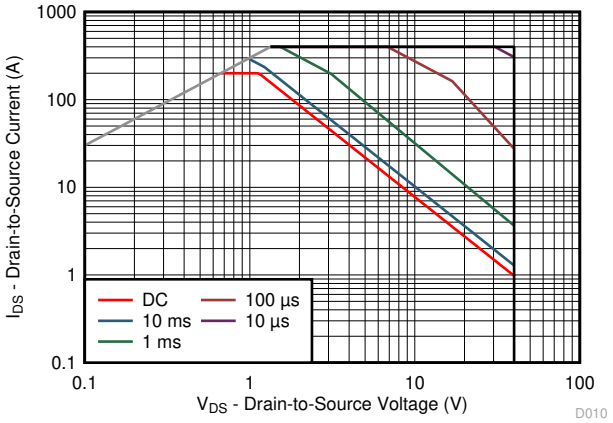


图 4-9. Typical Diode Forward Voltage

4.3 Typical MOSFET Characteristics (continued)

T_A =25°C (unless otherwise stated)



Single pulse, max $R_{\theta JC}$ = 0.6°C/W

图 4-10. Maximum Safe Operating Area

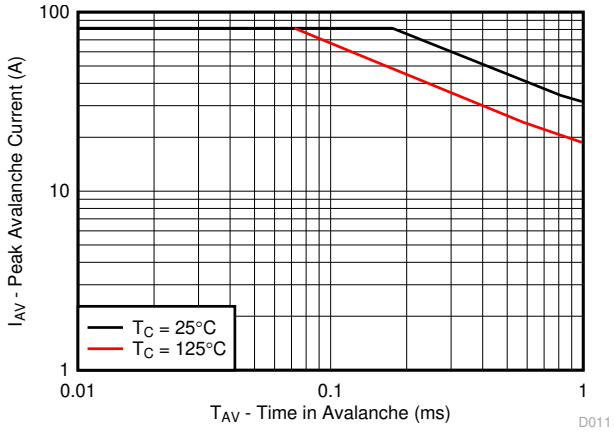
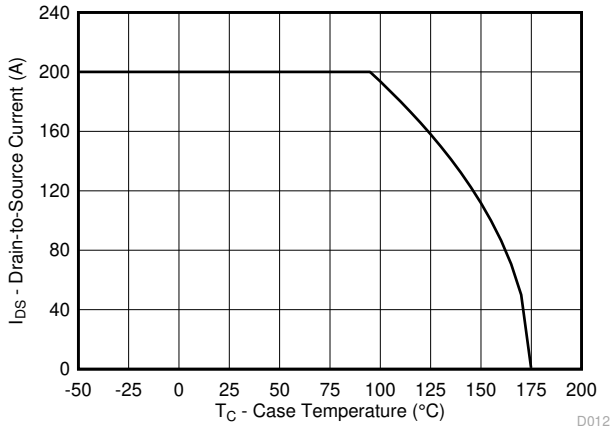


图 4-11. Single Pulse Unclamped Inductive Switching



Max $R_{\theta JC}$ = 0.6°C/W

图 4-12. Maximum Drain Current vs Temperature

5 器件和文档支持

5.1 接收文档更新通知

要接收文档更新通知，请导航至 ti.com 上的器件产品文件夹。点击*通知* 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

5.2 支持资源

TI E2E™ 中文支持论坛是工程师的重要参考资料，可直接从专家处获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题，获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的使用条款。

5.3 Trademarks

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所有商标均为其各自所有者的财产。

5.4 静电放电警告

静电放电 (ESD) 会损坏这个集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

5.5 术语表

TI 术语表　　本术语表列出并解释了术语、首字母缩略词和定义。

6 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision B (November 2022) to Revision C (June 2024)	Page
• 更新了整个文档中的表格、图和交叉参考的编号格式	1

Changes from Revision A (January 2017) to Revision B (November 2022)	Page
• Updated 图 4-3	4

Changes from Revision * (November 2016) to Revision A (January 2017)	Page
• 在*绝对最大额定值* 表中将 T_C = 25°C 时的器件电流限制从 237A 更改为 274A	1
• 在*绝对最大额定值* 表中将 T_C = 100°C 时的器件电流限制从 167A 更改为 193A	1
• 在*绝对最大额定值* 表中将最大功耗从 188W 更改为 250W	1
• Changed the charge values in the Dynamic Characteristics section of the *Electrical Characteristics* table	3
• Changed max $R_{\theta JC}$ from 0.8°C/W : to 0.6°C/W in the *Thermal Information* table	3
• Changed 图 4-4 in the *Typical MOSFET Characteristics* section to reflect updated gate charges	4

7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CSD18510KTT	Active	Production	DDPAK/ TO-263 (KTT) | 2	500 | LARGE T&R	ROHS Exempt	SN	Level-2-260C-1 YEAR	-55 to 175	CSD18510KTT
CSD18510KTT.B	Active	Production	DDPAK/ TO-263 (KTT) | 2	500 | LARGE T&R	ROHS Exempt	SN	Level-2-260C-1 YEAR	-55 to 175	CSD18510KTT
CSD18510KTTT	Active	Production	DDPAK/ TO-263 (KTT) | 2	50 | SMALL T&R	ROHS Exempt	SN	Level-2-260C-1 YEAR	-55 to 175	CSD18510KTT
CSD18510KTTT.B	Active	Production	DDPAK/ TO-263 (KTT) | 2	50 | SMALL T&R	ROHS Exempt	SN	Level-2-260C-1 YEAR	-55 to 175	CSD18510KTT

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

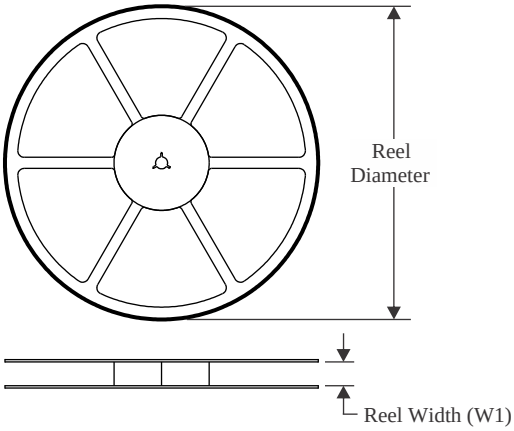
(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

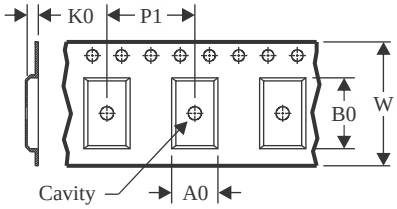
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

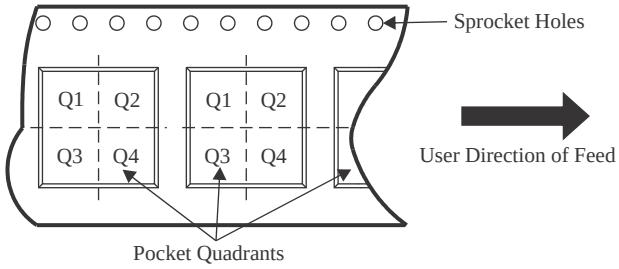


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

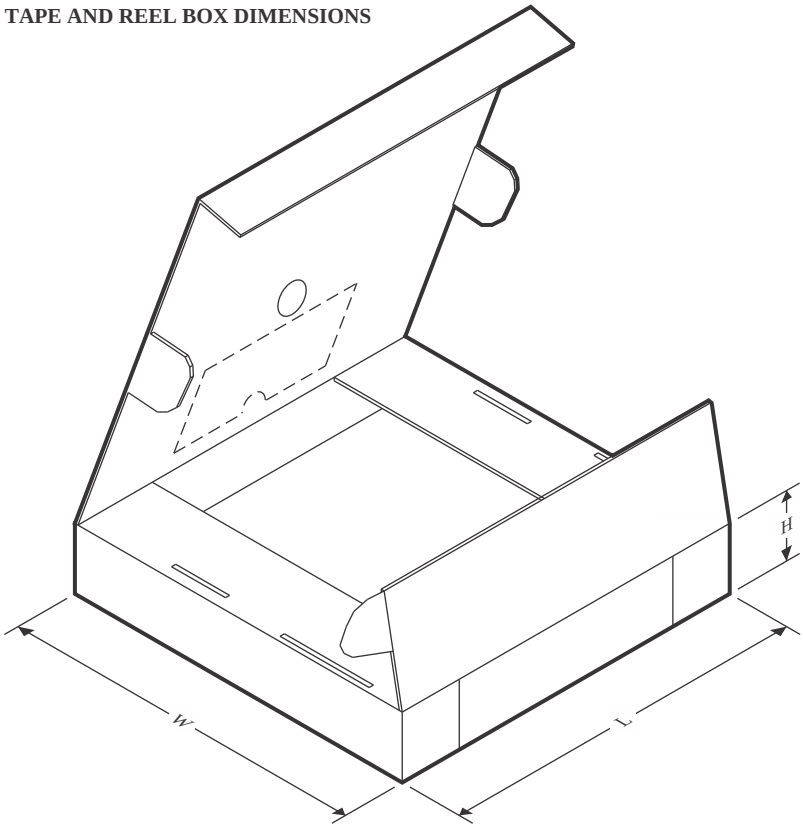
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD18510KTT	DDPAK/ TO-263	KTT	2	500	330.0	24.4	10.8	16.3	5.11	16.0	24.0	Q2
CSD18510KTTT	DDPAK/ TO-263	KTT	2	50	330.0	24.4	10.8	16.3	5.11	16.0	24.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

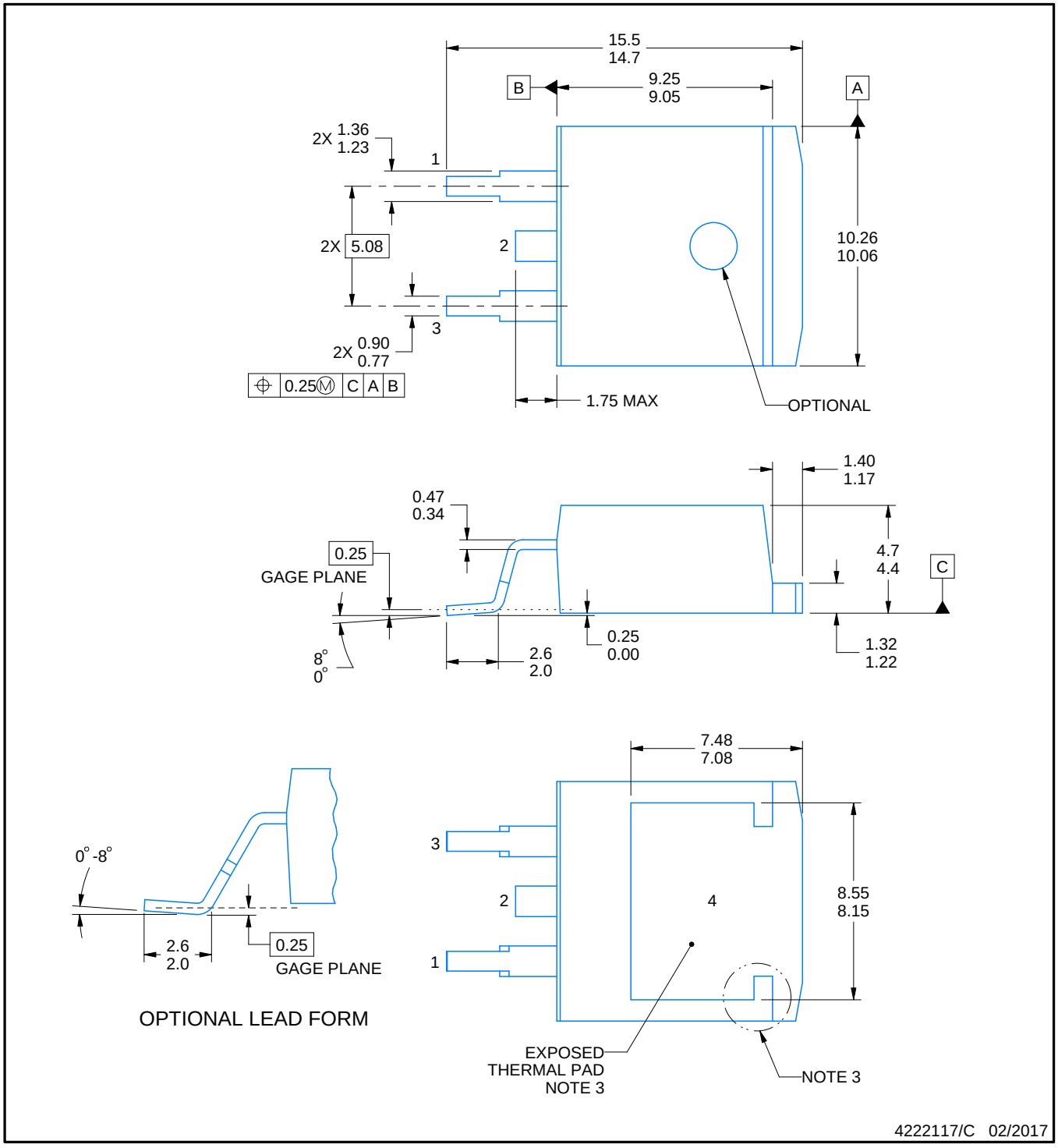
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD18510KTT	DDPAK/TO-263	KTT	2	500	340.0	340.0	38.0
CSD18510KTTT	DDPAK/TO-263	KTT	2	50	340.0	340.0	38.0

KTT0002A

PACKAGE OUTLINE

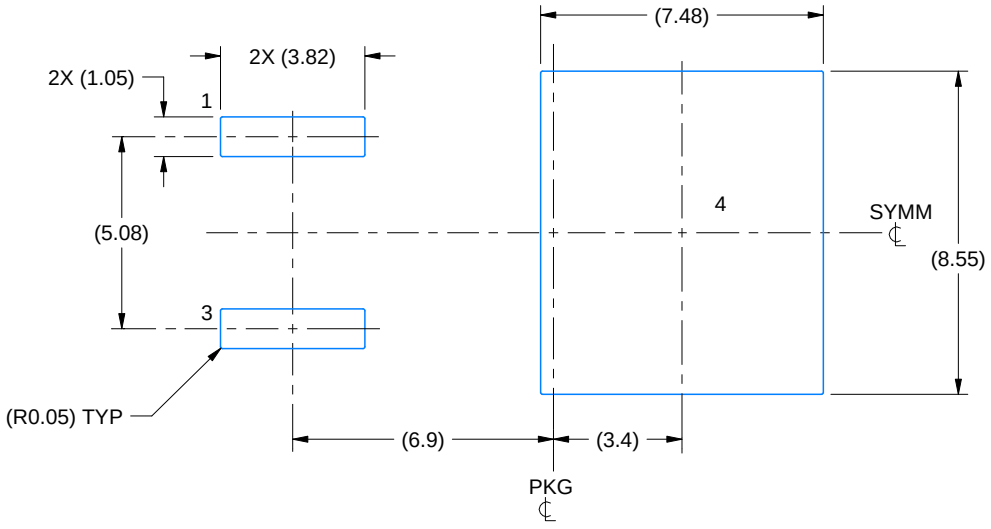
TO-263 - 4.7 mm max height

TO-263

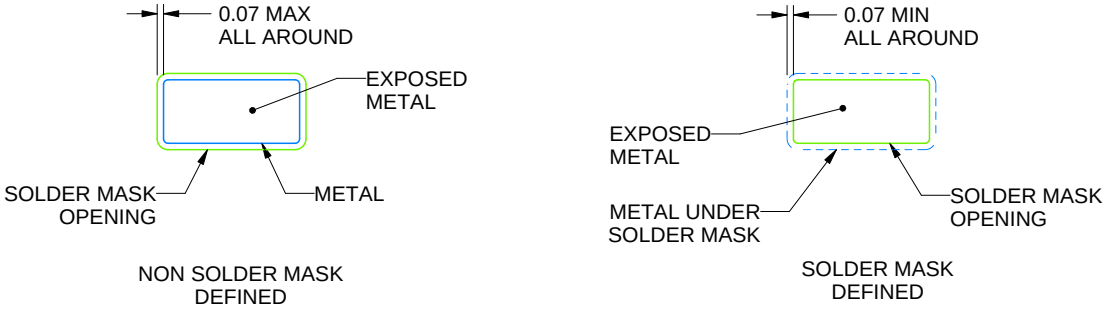


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Features may not exist and shape may vary per different assembly sites.
4. Reference JEDEC registration TO-263.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:5X

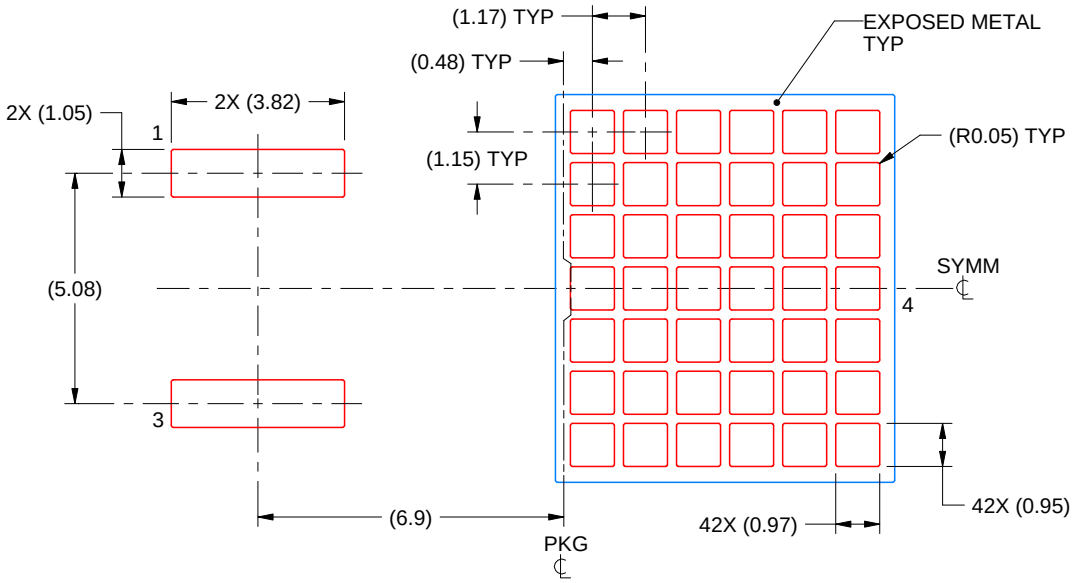


SOLDER MASK DETAILS

4222117/C 02/2017

NOTES: (continued)

5. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002(www.ti.com/lit/slm002) and SLMA004 (www.ti.com/lit/slma004).
6. Vias are optional depending on application, refer to device data sheet. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
60.5% PRINTED SOLDER COVERAGE BY AREA
SCALE:6X

4222117/C 02/2017

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

重要通知和免责声明

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